

Thyristor \ Diode Module

= 2x 1800 V

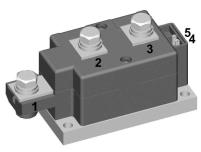
320 A

 V_{τ} 1.06 V

Phase leg

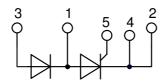
Part number

MCD312-18io1



Backside: isolated





Features / Advantages:

- International standard package
- Direct copper bonded Al2O3-ceramic with copper base plate
- Planar passivated chip
- Isolation voltage 3600 V~
- Keyed gate/cathode twin pins

Applications:

- Motor control, softstarter
- Power converter
- · Heat and temperature control for industrial furnaces and chemical processes
- Lighting control
- Solid state switches

Package: Y1

- Isolation Voltage: 3600 V~
- Industry standard outline
- RoHS compliant
- Base plate: Copper internally DCB isolated
- Advanced power cycling

Terms _Conditions of usage:

The data contained in this product data sheet is exclusively intended for technically trained staff. The user will have to evaluate the suitability of the product for the intended application and the completeness of the product data with respect to his application. The specifications of our components may not be considered as an assurance of component characteristics. The information in the valid application- and assembly notes must be considered. Should you require product information in excess of the data given in this product data sheet or which concerns the specific application of your product, please contact the sales office, which is responsible for you.

Due to technical requirements our product may contain dangerous substances. For information on the types in question please contact the sales office, which is responsible for you.

Should you intend to use the product in aviation, in health or live endangering or life support applications, please notify. For any such application we urgently recommend

- to perform joint risk and quality assessments; the conclusion of quality agreements;
- to establish joint measures of an ongoing product survey, and that we may make delivery dependent on the realization of any such measures.

IXYS reserves the right to change limits, conditions and dimensions.

Data according to IEC 60747 and per semiconductor unless otherwise specified



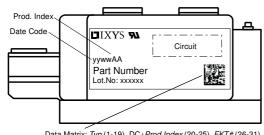
Rectifier				 1	Ratings	S	1
Symbol	Definition	Conditions		min.	typ.	max.	Unit
V _{RSM/DSM}	max. non-repetitive reverse/forwa	ard blocking voltage	$T_{VJ} = 25^{\circ}C$			1900	V
V _{RRM/DRM}	max. repetitive reverse/forward b	locking voltage	$T_{VJ} = 25^{\circ}C$			1800	V
I _{R/D}	reverse current, drain current	$V_{R/D} = 1800 \text{ V}$	$T_{VJ} = 25^{\circ}C$			1	mA
		$V_{R/D} = 1800 \text{ V}$	$T_{VJ} = 140$ °C			40	mΑ
V_{T}	forward voltage drop	$I_T = 300 A$	$T_{VJ} = 25^{\circ}C$			1.12	V
		$I_{T} = 600 \text{ A}$				1.32	٧
		$I_T = 300 A$	$T_{VJ} = 125$ °C			1.06	V
		$I_{T} = 600 \text{ A}$				1.29	V
I _{TAV}	average forward current	$T_c = 85^{\circ}C$	$T_{VJ} = 140$ °C			320	Α
I _{T(RMS)}	RMS forward current	180° sine				520	Α
V _{T0}	threshold voltage \ for power!	oss calculation only	$T_{VJ} = 140$ °C			0.80	٧
r _T	slope resistance	oss calculation only				0.68	mΩ
R _{thJC}	thermal resistance junction to cas	se				0.12	K/W
R _{thCH}	thermal resistance case to heats	ink			0.04		K/W
P _{tot}	total power dissipation		$T_{C} = 25^{\circ}C$			960	W
I _{TSM}	max. forward surge current	t = 10 ms; (50 Hz), sine	$T_{VJ} = 45^{\circ}C$			9.60	kA
		t = 8.3 ms; (60 Hz), sine	$V_R = 0 V$			10.4	kA
		t = 10 ms; (50 Hz), sine	T _{vJ} = 140°C			8.16	kA
		t = 8.3 ms; (60 Hz), sine	$V_R = 0 V$			8.82	kA
l²t	value for fusing	t = 10 ms; (50 Hz), sine	$T_{VJ} = 45^{\circ}C$			460.8	kA2s
		t = 8,3 ms; (60 Hz), sine	$V_R = 0 V$			447.4	kA2s
		t = 10 ms; (50 Hz), sine	T _{vJ} = 140°C			332.9	kA2s
		t = 8,3 ms; (60 Hz), sine	$V_R = 0 V$			323.3	kA2s
C _J	junction capacitance	$V_R = 400 V$ $f = 1 MHz$	$T_{VJ} = 25^{\circ}C$		438		рF
P _{GM}	max. gate power dissipation	t _P = 30 μs	T _C = 140°C			120	W
		$t_{P} = 500 \mu s$				60	W
P_{GAV}	average gate power dissipation					20	W
(di/dt) _{cr}	critical rate of rise of current	$T_{VJ} = 140 ^{\circ}\text{C}; f = 50 \text{Hz}$	epetitive, $I_T = 960 \text{ A}$			100	A/μs
, ,		$t_P = 200 \mu s; di_G/dt = 1 A/\mu s; -$! ! !
			on-repet., $I_{T} = 320 \text{ A}$			500	A/μs
(dv/dt) _{cr}	critical rate of rise of voltage	$V = \frac{2}{3} V_{DBM}$	T _{v.i} = 140°C			1000	
(701	· ·	R _{GK} = ∞; method 1 (linear volta	• •				! " ! !
V _{GT}	gate trigger voltage	$V_D = 6 \text{ V}$	$T_{VJ} = 25^{\circ}C$			2	V
- 01		5	$T_{VJ} = -40$ °C			3	٧
I _{GT}	gate trigger current	$V_D = 6 \text{ V}$	$T_{VJ} = 25^{\circ}C$			150	mA
•G1	gane angger com em		$T_{VJ} = -40$ °C			220	mA
V _{GD}	gate non-trigger voltage	$V_D = \frac{2}{3} V_{DBM}$	$T_{VJ} = 140^{\circ}C$			0.25	V
I _{GD}	gate non-trigger current	- D — 🗸 • ОНМ	. ,, –			10	mA
I _L	latching current	t _p = 30 μs	T _{VJ} = 25°C			200	mA
·L	atoming outfork	$I_p = 30 \mu s$ $I_G = 0.45 \text{ A}; di_G/dt = 0.45 \text{ A}/\mu s$				200	шА
	holding current	$V_D = 6 \text{ V } R_{GK} = \infty$	$T_{VJ} = 25 ^{\circ}\text{C}$			150	mA
I _H			$T_{VJ} = 25^{\circ}C$ $T_{VJ} = 25^{\circ}C$				İ
t _{gd}	gate controlled delay time	$V_D = \frac{1}{2} V_{DRM}$				2	μs
	turn off time	$I_{\rm G} = 1 \text{A}; \text{di}_{\rm G}/\text{dt} = 1 \text{A}/\mu \text{s}$			000		i !
tq	turn-off time	$V_R = 100 \text{ V}; I_T = 300 \text{ A}; V = \frac{2}{3}$			200		μs
		$di/dt = 10 A/\mu s dv/dt = 50 V$	$t/\mu s t_p = 200 \mu s$				í L

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Package Y1				Ratings			
Symbol	Definition	Conditions		min.	typ.	max.	Unit
I _{RMS}	RMS current	per terminal				600	Α
T _{VJ}	virtual junction temperature			-40		140	°C
T _{op}	operation temperature			-40		125	°C
T _{stg}	storage temperature		-40		125	°C	
Weight					680		g
M _D	mounting torque			4.5		7	Nm
$\mathbf{M}_{\scriptscriptstyleT}$	terminal torque			11		13	Nm
d _{Spp/App}	avenues distance on confess latribine distance through	ilking diatanaa thraugh air	terminal to terminal	16.0			mm
d _{Spb/Apb}	creepage distance on surface striking distance through a		terminal to backside	16.0			mm
V _{ISOL}	isolation voltage	t = 1 second		3600			٧
1002	50/60 Hz, RMS; liso∟ ≤ 1 i t = 1 minute		50/60 Hz, RMS; IISOL ≤ 1 mA	3000			٧



Data Matrix: Typ (1-19), DC+Prod.Index (20-25), FKT# (26-31) leer (33), Ifd.# (33-36)

Ordering	Ordering Number	Marking on Product	Delivery Mode	Quantity	Code No.
Standard	MCD312-18io1	MCD312-18io1	Box	3	461865

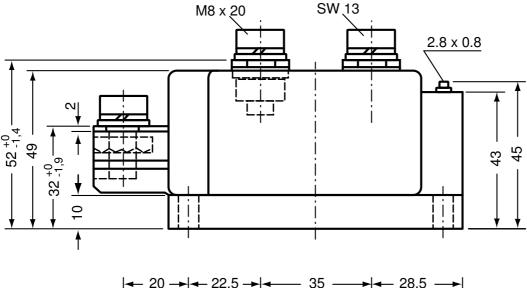
Equivalent Circuits for Simulation			* on die level	$T_{VJ} = 140 ^{\circ}\text{C}$
$I \rightarrow V_0$	R _o	Thyristor		
V _{0 max}	threshold voltage	8.0		V
$R_{0 \text{ max}}$	slope resistance *	0.5		$m\Omega$

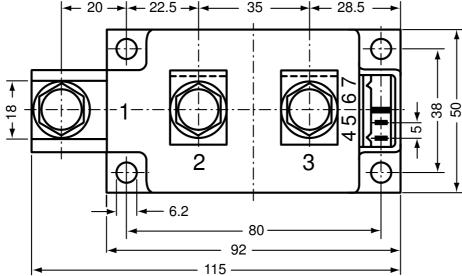
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Outlines Y1

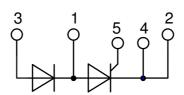




Optional accessories for modules

Keyed gate/cathode twin plugs with wire length = 350 mm, gate = white, cathode = red

Type ZY 180L (L = Left for pin pair 4/5) Type ZY 180R (R = Right for pin pair 6/7) $\right\}$ UL 758, style 3751





Thyristor

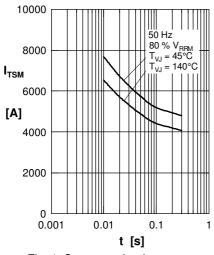


Fig. 1 Surge overload current I_{TSM}:Crest value, t: duration

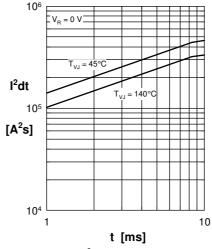


Fig. 2 I²dt versus time

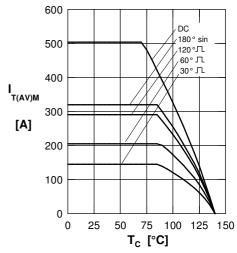


Fig. 3 Max. forward current at case temperature

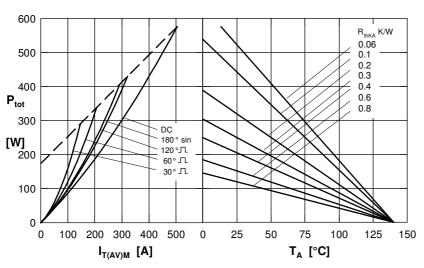


Fig. 4 Power dissipation versus on-state current and ambient temperature (per thyristor)

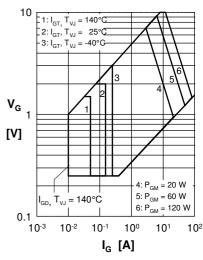


Fig. 5 Gate voltage & gate current

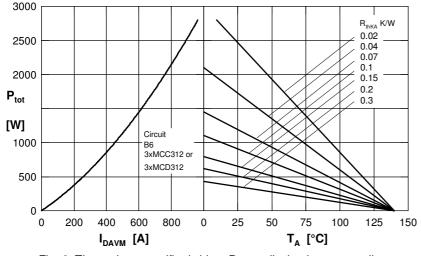


Fig. 6 Three phase rectifier bridge: Power dissipation versus direct output current and ambient temperature

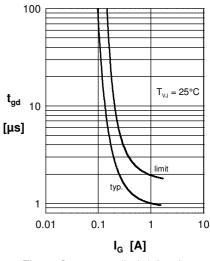


Fig. 7 Gate controlled delay time t_{qd}

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Rectifier

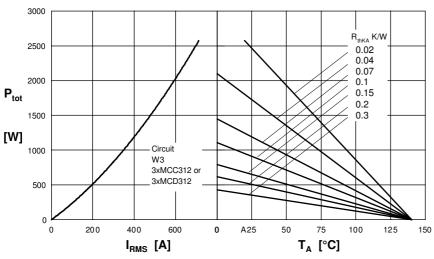


Fig. 8 Three phase AC-controller: Power dissipation versus $\rm R_{MS}$ output current and ambient temperature

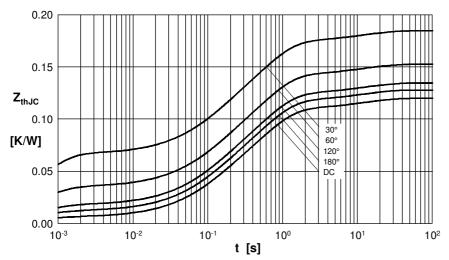


Fig. 9 Transient thermal impedance junction to case (per thyristor)

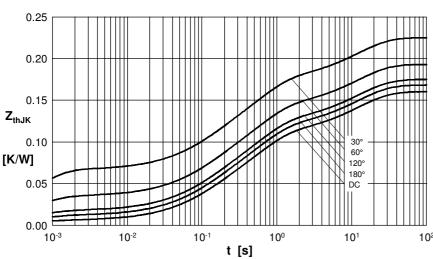


Fig. 10 Transient thermal impedance junction to heatsink (per thyristor)

 $\boldsymbol{R}_{\text{thJC}}$ for various conduct. angles d:

d	R _{thJC} [K/W]
DC	0.120
180°	0.128
120°	0.135
60°	0.153
30°	0.185

Constants for Z_{thJC} calculation:

i	R _{thi} [K/W]	t _i [s]
1	0.0058	0.00054
2	0.0310	0.098
3	0.0720	0.54
4	0.0112	12

 \mathbf{R}_{thJK} for various conduct. angles d:

d	R_{thJK} [K/W]
DC	0.160
180°	0.168
120°	0.175
60°	0.193
30°	0.225

Constants for Z_{thJK} calculation:

i	R_{thi} [K/W]	t _i [s]
1	0.0058	0.00054
2	0.0310	0.098
3	0.0720	0.54
4	0.0114	12
5	0.0400	12

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